



**THE DATASHEET OF  
NE5517DR2G**



# NE5517, NE5517A, AU5517

## Dual Operational Transconductance Amplifier

The AU5517 and NE5517 contain two current-controlled transconductance amplifiers, each with a differential input and push-pull output. The AU5517/NE5517 offers significant design and performance advantages over similar devices for all types of programmable gain applications. Circuit performance is enhanced through the use of linearizing diodes at the inputs which enable a 10 dB signal-to-noise improvement referenced to 0.5% THD. The AU5517/NE5517 is suited for a wide variety of industrial and consumer applications.

Constant impedance of the buffers on the chip allow general use of the AU5517/NE5517. These buffers are made of Darlington transistors and a biasing network that virtually eliminate the change of offset voltage due to a burst in the bias current  $I_{ABC}$ , hence eliminating the audible noise that could otherwise be heard in high quality audio applications.

### Features

- Constant Impedance Buffers
- $\Delta V_{BE}$  of Buffer is Constant with Amplifier  $I_{BIAS}$  Change
- Excellent Matching Between Amplifiers
- Linearizing Diodes
- High Output Signal-to-Noise Ratio
- Pb-Free Packages are Available\*

### Applications

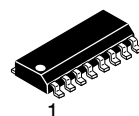
- Multiplexers
- Timers
- Electronic Music Synthesizers
- Dolby® HX Systems
- Current-Controlled Amplifiers, Filters
- Current-Controlled Oscillators, Impedances



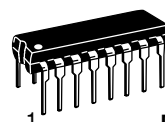
ON Semiconductor®

<http://onsemi.com>

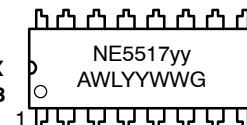
### MARKING DIAGRAMS



SOIC-16  
D SUFFIX  
CASE 751B

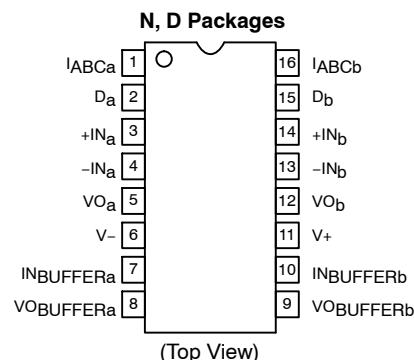


PDIP-16  
N SUFFIX  
CASE 648



xx = AU or NE  
yy = AN or N  
A = Assembly Location  
WL = Wafer Lot  
YY, Y = Year  
WW = Work Week  
G = Pb-Free Package

### PIN CONNECTIONS



### ORDERING INFORMATION

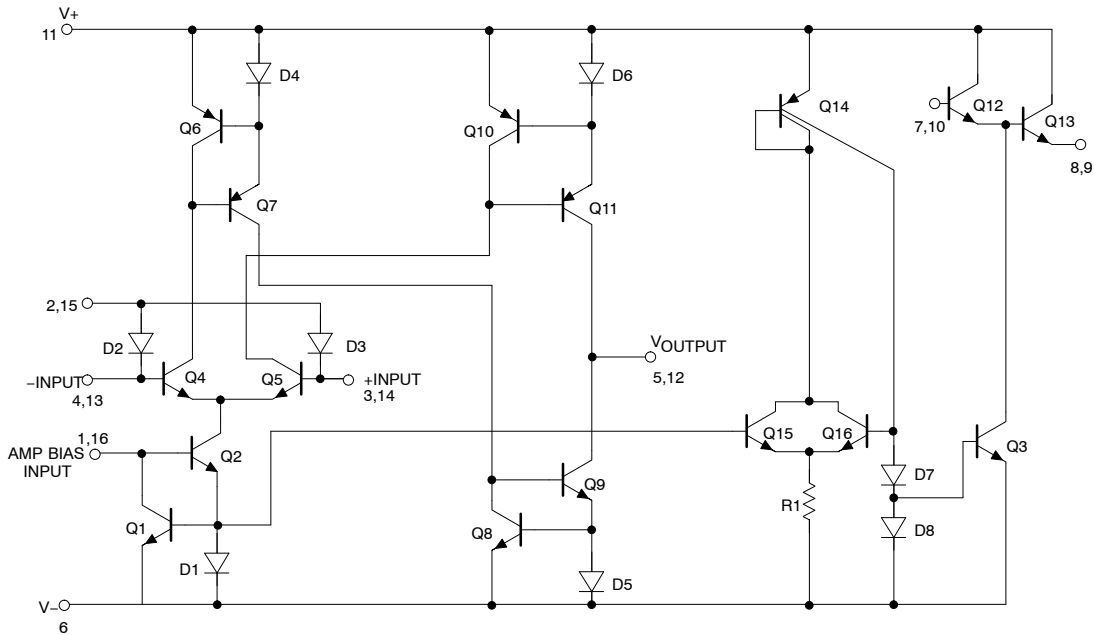
See detailed ordering and shipping information in the package dimensions section on page 13 of this data sheet.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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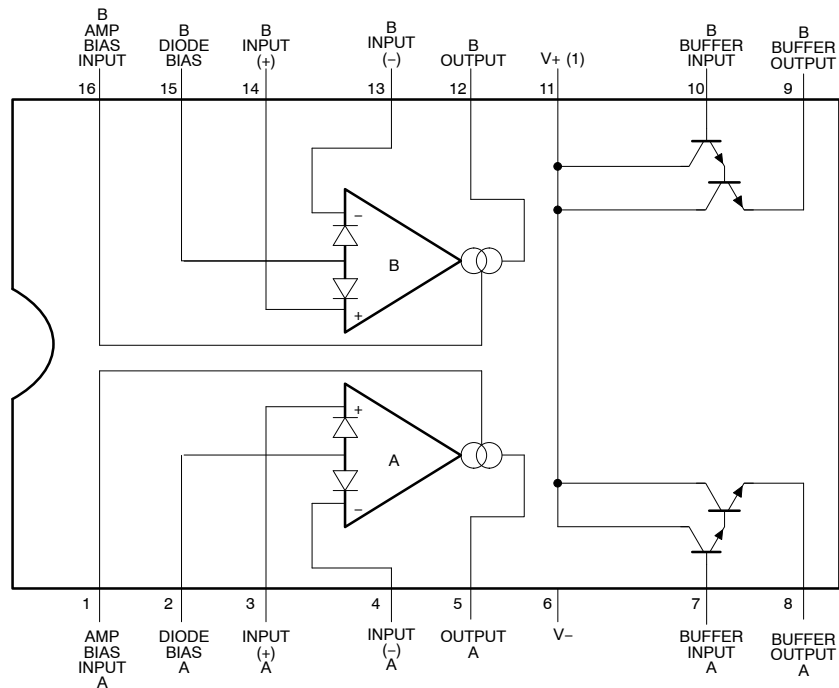
## PIN DESCRIPTION

| Pin No. | Symbol         | Description            |
|---------|----------------|------------------------|
| 1       | $I_{ABCa}$     | Amplifier Bias Input A |
| 2       | $D_a$          | Diode Bias A           |
| 3       | $+IN_a$        | Non-inverted Input A   |
| 4       | $-IN_a$        | Inverted Input A       |
| 5       | $VO_a$         | Output A               |
| 6       | $V_-$          | Negative Supply        |
| 7       | $IN_{BUFFERa}$ | Buffer Input A         |
| 8       | $VO_{BUFFERa}$ | Buffer Output A        |
| 9       | $VO_{BUFFERb}$ | Buffer Output B        |
| 10      | $IN_{BUFFERb}$ | Buffer Input B         |
| 11      | $V_+$          | Positive Supply        |
| 12      | $VO_b$         | Output B               |
| 13      | $-IN_b$        | Inverted Input B       |
| 14      | $+IN_b$        | Non-inverted Input B   |
| 15      | $D_b$          | Diode Bias B           |
| 16      | $I_{ABCb}$     | Amplifier Bias Input B |



**Figure 1. Circuit Schematic**

# NE5517, NE5517A, AU5517



NOTE:  $V_+$  of output buffers and amplifiers are internally connected.

Figure 2. Connection Diagram

## MAXIMUM RATINGS

| Rating  | Symbol          | Value   | Unit                      |
|---|-----------------|---|---------------------------|
| Supply Voltage (Note 1)   | $V_S$           | 44 $V_{DC}$ or $\pm 22$   | V                         |
| Power Dissipation, $T_{amb} = 25^\circ\text{C}$ (Still Air) (Note 2)<br>NE5517N, NE5517AN<br>NE5517D, AU5517D | $P_D$           | 1500<br>1125  | mW                        |
| Thermal Resistance, Junction-to-Ambient<br>D Package<br>N Package   | $R_{\theta JA}$ | 140<br>94   | $^\circ\text{C}/\text{W}$ |
| Differential Input Voltage  | $V_{IN}$        | $\pm 5.0$   | V                         |
| Diode Bias Current  | $I_D$           | 2.0   | mA                        |
| Amplifier Bias Current  | $I_{ABC}$       | 2.0   | mA                        |
| Output Short-Circuit Duration   | $I_{SC}$        | Indefinite  |                           |
| Buffer Output Current (Note 3)  | $I_{OUT}$       | 20  | mA                        |
| Operating Temperature Range<br>NE5517N, NE5517AN<br>AU5517T   | $T_{amb}$       | $0^\circ\text{C}$ to $+70^\circ\text{C}$<br>$-40^\circ\text{C}$ to $+125^\circ\text{C}$ | $^\circ\text{C}$          |
| Operating Junction Temperature  | $T_J$           | 150   | $^\circ\text{C}$          |
| DC Input Voltage  | $V_{DC}$        | $+V_S$ to $-V_S$  |                           |
| Storage Temperature Range   | $T_{stg}$       | $-65^\circ\text{C}$ to $+150^\circ\text{C}$   | $^\circ\text{C}$          |
| Lead Soldering Temperature (10 sec max)   | $T_{slid}$      | 230   | $^\circ\text{C}$          |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- For selections to a supply voltage above  $\pm 22$  V, contact factory.
- The following derating factors should be applied above  $25^\circ\text{C}$   
N package at  $10.6\text{ mW}/^\circ\text{C}$   
D package at  $7.1\text{ mW}/^\circ\text{C}$ .
- Buffer output current should be limited so as to not exceed package dissipation.

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## ELECTRICAL CHARACTERISTICS (Note 4)

| Characteristic                               | Test Conditions  | Symbol        | AU5517/NE5517 |                |            | NE5517A           |                |                   | Unit              |
|--|--|---------------|---------------|----------------|------------|-------------------|----------------|-------------------|-------------------|
|  |  |               | Min           | Typ            | Max        | Min               | Typ            | Max               |                   |
| Input Offset Voltage                         | Overtemperature Range<br>$I_{ABC} = 5.0 \mu A$   | $V_{OS}$      |               | 0.4<br>0.3     | 5.0<br>5.0 |                   | 0.4<br>0.3     | 2.0<br>5.0<br>2.0 | mV                |
| $\Delta V_{OS}/\Delta T$                     | Avg. TC of Input Offset Voltage  |               |               | 7.0            |            |                   | 7.0            |                   | $\mu V/^{\circ}C$ |
| $V_{OS}$ Including Diodes                    | Diode Bias Current<br>( $I_D$ ) = 500 $\mu A$  |               |               | 0.5            | 5          |                   | 0.5            | 2.0               | mV                |
| Input Offset Change                          | $5.0 \mu A \leq I_{ABC} \leq 500 \mu A$  | $V_{OS}$      |               | 0.1            |            |                   | 0.1            | 3.0               | mV                |
| Input Offset Current                         |  | $I_{OS}$      |               | 0.1            | 0.6        |                   | 0.1            | 0.6               | $\mu A$           |
| $\Delta I_{OS}/\Delta T$                     | Avg. TC of Input Offset Current  |               |               | 0.001          |            |                   | 0.001          |                   | $\mu A/^{\circ}C$ |
| Input Bias Current                           | Overtemperature Range  | $I_{BIAS}$    |               | 0.4<br>1.0     | 5.0<br>8.0 |                   | 0.4<br>1.0     | 5.0<br>7.0        | $\mu A$           |
| $\Delta I_B/\Delta T$                        | Avg. TC of Input Current   |               |               | 0.01           |            |                   | 0.01           |                   | $\mu A/^{\circ}C$ |
| Forward Transconductance                     | Overtemperature Range  | $g_M$         | 6700<br>5400  | 9600           | 13000      | 7700<br>4000      | 9600           | 12000             | $\mu mho$         |
| $g_M$ Tracking                               |  |               |               | 0.3            |            |                   | 0.3            |                   | dB                |
| Peak Output Current                          | $R_L = 0, I_{ABC} = 5.0 \mu A$<br>$R_L = 0, I_{ABC} = 500 \mu A$<br>$R_L = 0, \text{Overtemperature Range}$    | $I_{OUT}$     | 350<br>300    | 5.0<br>500     | 650        | 3.0<br>350<br>300 | 5.0<br>500     | 7.0<br>650        | $\mu A$           |
| Peak Output Voltage<br>Positive<br>Negative  | $R_L = \infty, 5.0 \mu A \leq I_{ABC} \leq 500 \mu A$<br>$R_L = \infty, 5.0 \mu A \leq I_{ABC} \leq 500 \mu A$ | $V_{OUT}$     | +12<br>-12    | +14.2<br>-14.4 |            | +12<br>-12        | +14.2<br>-14.4 |                   | V                 |
| Supply Current                               | $I_{ABC} = 500 \mu A$ , both channels  | $I_{CC}$      |               | 2.6            | 4.0        |                   | 2.6            | 4.0               | mA                |
| $V_{OS}$ Sensitivity<br>Positive<br>Negative | $\Delta V_{OS}/\Delta V_+$<br>$\Delta V_{OS}/\Delta V_-$   |               |               | 20<br>20       | 150<br>150 |                   | 20<br>20       | 150<br>150        | $\mu V/V$         |
| Common-mode Rejection<br>Ratio               |  | CMRR          | 80            | 110            |            | 80                | 110            |                   | dB                |
| Common-mode Range                            |  |               | $\pm 12$      | $\pm 13.5$     |            | $\pm 12$          | $\pm 13.5$     |                   | V                 |
| Crosstalk                                    | Referred to Input (Note 5)<br>20 Hz < f < 20 kHz   |               |               | 100            |            |                   | 100            |                   | dB                |
| Differential Input Current                   | $I_{ABC} = 0$ , Input = $\pm 4.0$ V  | $I_{IN}$      |               | 0.02           | 100        |                   | 0.02           | 10                | nA                |
| Leakage Current                              | $I_{ABC} = 0$ (Refer to Test Circuit)  |               |               | 0.2            | 100        |                   | 0.2            | 5.0               | nA                |
| Input Resistance                             |  | $R_{IN}$      | 10            | 26             |            | 10                | 26             |                   | k $\Omega$        |
| Open-loop Bandwidth                          |  | BW            |               | 2.0            |            |                   | 2.0            |                   | MHz               |
| Slew Rate                                    | Unity Gain Compensated   | SR            |               | 50             |            |                   | 50             |                   | V/ $\mu s$        |
| Buffer Input Current                         | 5  | $I_{NBUFFER}$ |               | 0.4            | 5.0        |                   | 0.4            | 5.0               | $\mu A$           |
| Peak Buffer Output Voltage                   | 5  | $V_{OBUFFER}$ | 10            |                |            | 10                |                |                   | V                 |
| $\Delta V_{BE}$ of Buffer                    | Refer to Buffer $V_{BE}$ Test<br>Circuit (Note 6)  |               |               | 0.5            | 5.0        |                   | 0.5            | 5.0               | mV                |

4. These specifications apply for  $V_S = \pm 15$  V,  $T_{amb} = 25^{\circ}C$ , amplifier bias current ( $I_{ABC}$ ) = 500  $\mu A$ , Pins 2 and 15 open unless otherwise specified. The inputs to the buffers are grounded and outputs are open.

5. These specifications apply for  $V_S = \pm 15$  V,  $I_{ABC} = 500 \mu A$ ,  $R_{OUT} = 5.0$  k $\Omega$  connected from the buffer output to  $-V_S$  and the input of the buffer is connected to the transconductance amplifier output.

6.  $V_S = \pm 15$ ,  $R_{OUT} = 5.0$  k $\Omega$  connected from Buffer output to  $-V_S$  and  $5.0 \mu A \leq I_{ABC} \leq 500 \mu A$ .

TYPICAL PERFORMANCE CHARACTERISTICS

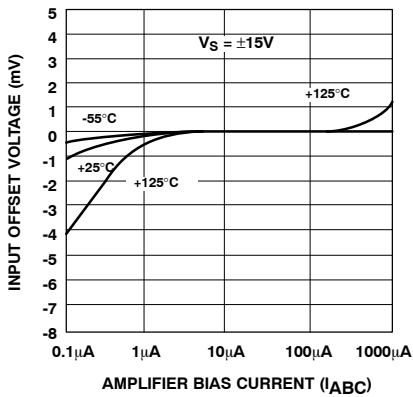


Figure 3. Input Offset Voltage

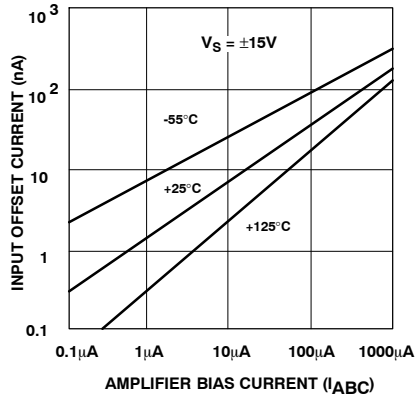


Figure 4. Input Bias Current

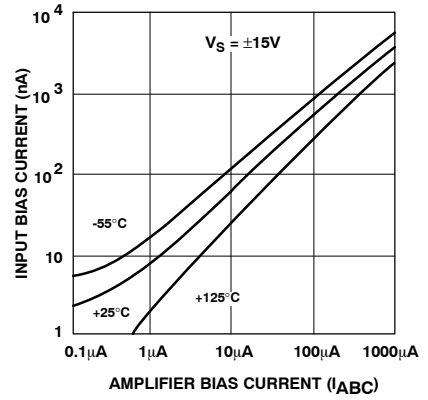


Figure 5. Input Bias Current

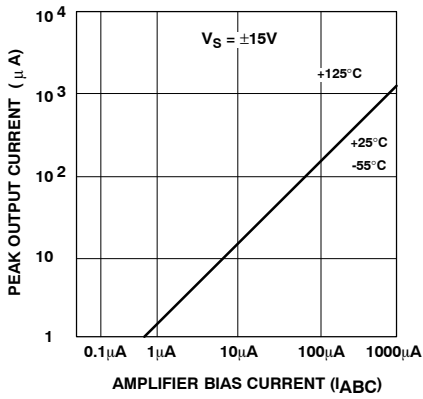


Figure 6. Peak Output Current

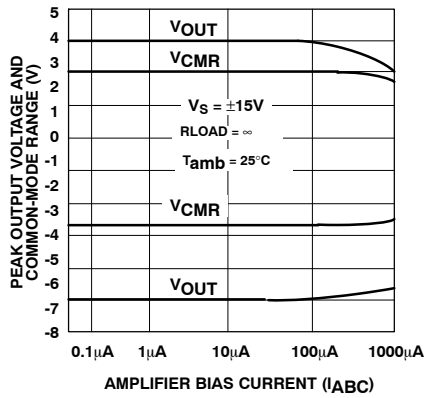


Figure 7. Peak Output Voltage and Common-Mode Range

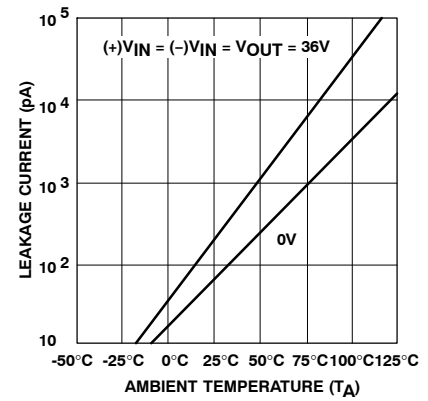


Figure 8. Leakage Current

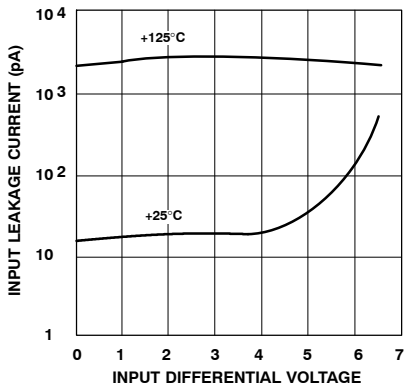


Figure 9. Input Leakage

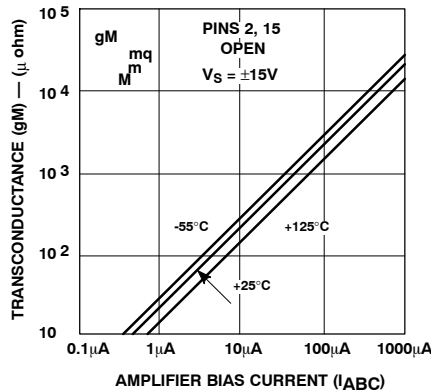


Figure 10. Transconductance

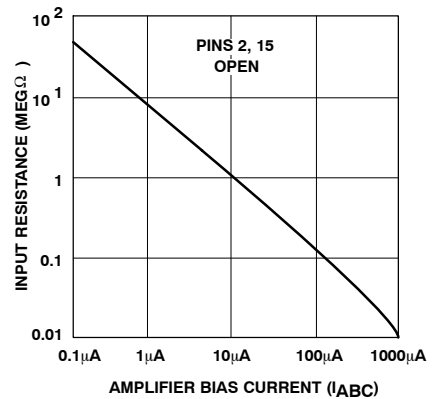


Figure 11. Input Resistance

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## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

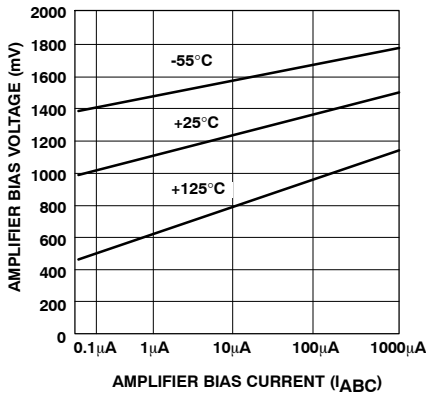


Figure 12. Amplifier Bias Voltage vs. Amplifier Bias Current

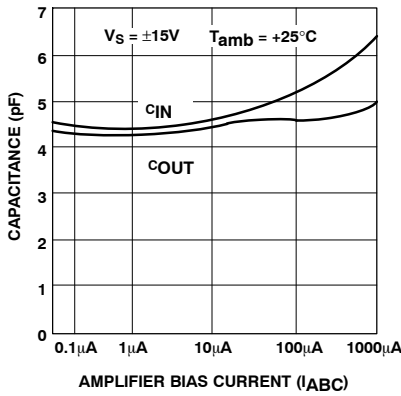


Figure 13. Input and Output Capacitance

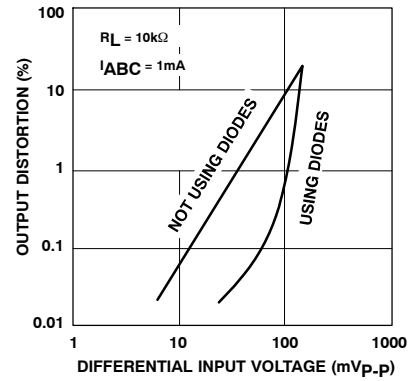


Figure 14. Distortion vs. Differential Input Voltage

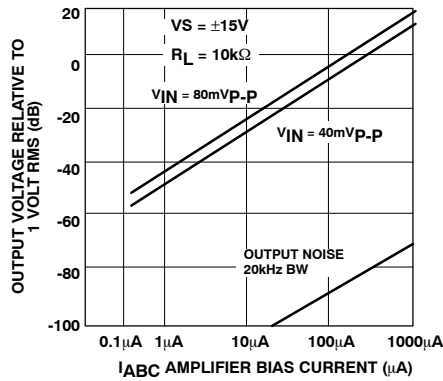


Figure 15. Voltage vs. Amplifier Bias Current

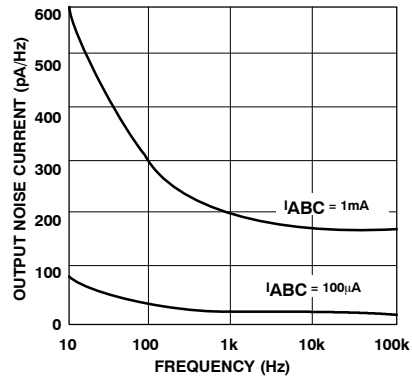


Figure 16. Noise vs. Frequency

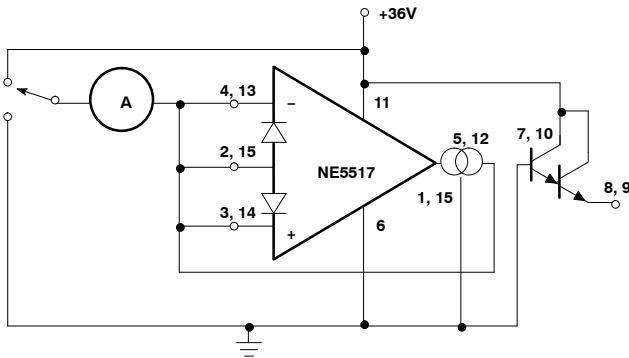


Figure 17. Leakage Current Test Circuit

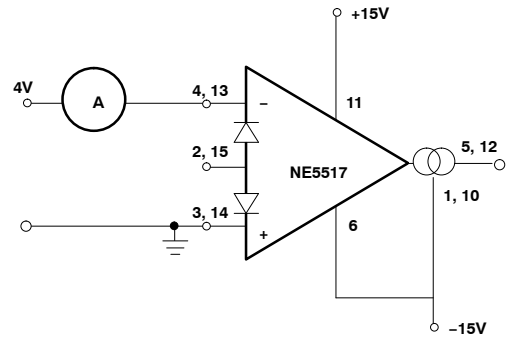


Figure 18. Differential Input Current Test Circuit

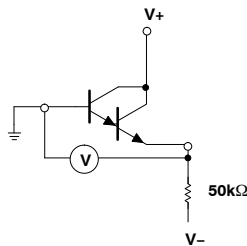


Figure 19. Buffer  $V_{BE}$  Test Circuit

APPLICATIONS

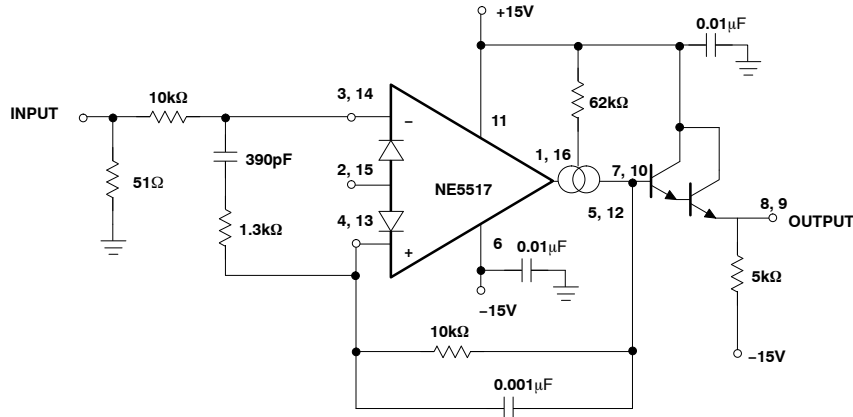


Figure 20. Unity Gain Follower

CIRCUIT DESCRIPTION

The circuit schematic diagram of one-half of the AU5517/NE5517, a dual operational transconductance amplifier with linearizing diodes and impedance buffers, is shown in Figure 21.

Transconductance Amplifier

The transistor pair, Q<sub>4</sub> and Q<sub>5</sub>, forms a transconductance stage. The ratio of their collector currents (I<sub>4</sub> and I<sub>5</sub>, respectively) is defined by the differential input voltage, V<sub>IN</sub>, which is shown in Equation 1.

$$V_{IN} = \frac{KT}{q} \ln \frac{I_5}{I_4} \quad (\text{eq. 1})$$

Where V<sub>IN</sub> is the difference of the two input voltages

KT ≅ 26 mV at room temperature (300°K).

Transistors Q<sub>1</sub>, Q<sub>2</sub> and diode D<sub>1</sub> form a current mirror which focuses the sum of current I<sub>4</sub> and I<sub>5</sub> to be equal to amplifier bias current I<sub>B</sub>:

$$I_4 + I_5 = I_B \quad (\text{eq. 2})$$

If V<sub>IN</sub> is small, the ratio of I<sub>5</sub> and I<sub>4</sub> will approach unity and the Taylor series of ln function can be approximated as

$$\frac{KT}{q} \ln \frac{I_5}{I_4} \approx \frac{KT}{q} \frac{I_5 - I_4}{I_4} \quad (\text{eq. 3})$$

$$\text{and } I_4 \cong I_5 \cong I_B$$

$$\frac{KT}{q} \ln \frac{I_5}{I_4} \approx \frac{KT}{q} \frac{I_5 - I_4}{1/2 I_B} = \frac{2KT}{q} \frac{I_5 - I_4}{I_B} = V_{IN} \quad (\text{eq. 4})$$

$$I_5 - I_4 = V_{IN} \frac{(I_B)^q}{2KT}$$

The remaining transistors (Q<sub>6</sub> to Q<sub>11</sub>) and diodes (D<sub>4</sub> to D<sub>6</sub>) form three current mirrors that produce an output current equal to I<sub>5</sub> minus I<sub>4</sub>. Thus:

$$V_{IN} \left( \frac{I_B^q}{2KT} \right) = I_O \quad (\text{eq. 5})$$

The term  $\frac{(I_B)^q}{2KT}$  is then the transconductance of the amplifier and is proportional to I<sub>B</sub>.

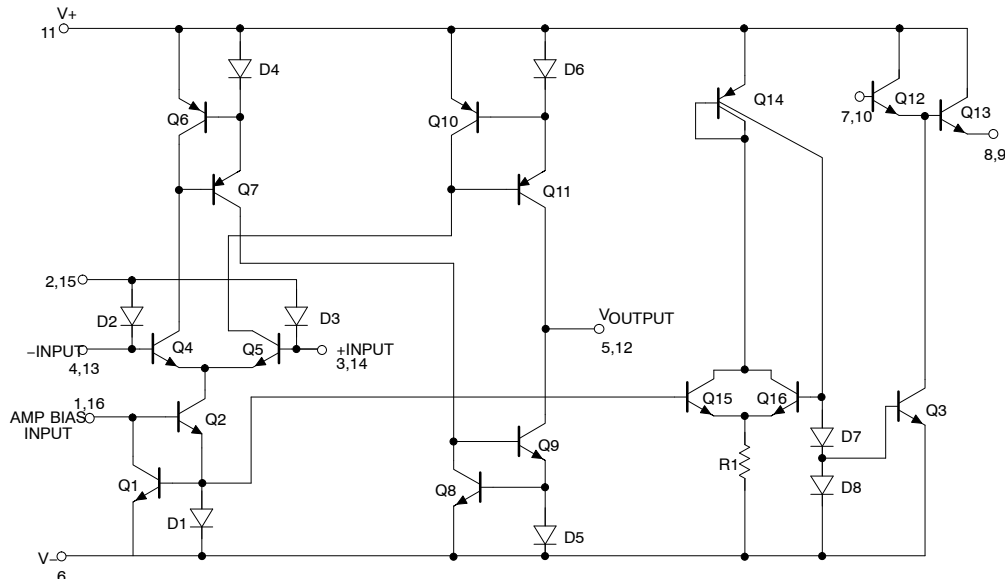


Figure 21. Circuit Diagram of NE5517



# NE5517, NE5517A, AU5517

## Stereo Amplifier With Gain Control

Figure 24 shows a stereo amplifier with variable gain via a control input. Excellent tracking of typical 0.3 dB is easy to achieve. With the potentiometer,  $R_P$ , the offset can be adjusted. For AC-coupled amplifiers, the potentiometer may be replaced with two 510  $\Omega$  resistors.

## Modulators

Because the transconductance of an OTA (Operational Transconductance Amplifier) is directly proportional to  $I_{ABC}$ , the amplification of a signal can be controlled easily. The output current is the product from transconductance  $\times$  input voltage. The circuit is effective up to approximately 200 kHz. Modulation of 99% is easy to achieve.

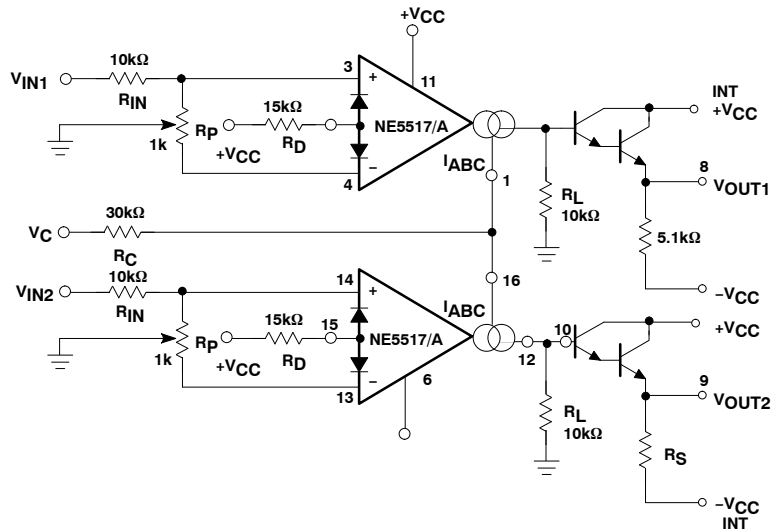


Figure 24. Gain-Controlled Stereo Amplifier

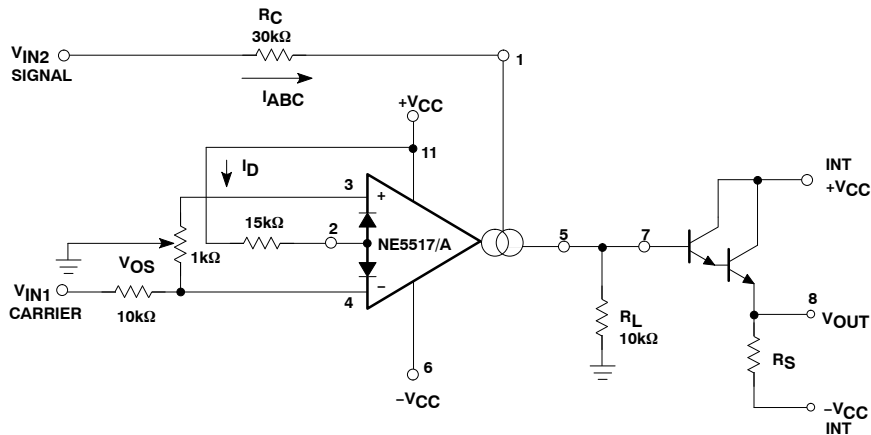


Figure 25. Amplitude Modulator

**Voltage-Controlled Resistor (VCR)**

Because an OTA is capable of producing an output current proportional to the input voltage, a voltage variable resistor can be made. Figure 26 shows how this is done. A voltage presented at the  $R_X$  terminals forces a voltage at the input. This voltage is multiplied by  $g_M$  and thereby forces a current through the  $R_X$  terminals:

$$R_x = \frac{R + R_A}{g_M + R_A}$$

where  $g_M$  is approximately 19.21  $\mu$ MHOs at room temperature. Figure 27 shows a Voltage Controlled Resistor using linearizing diodes. This improves the noise performance of the resistor.

**Voltage-Controlled Filters**

Figure 28 shows a Voltage Controlled Low-Pass Filter. The circuit is a unity gain buffer until  $X_C/g_M$  is equal to  $R/R_A$ . Then, the frequency response rolls off at a 6dB per octave with the -3 dB point being defined by the given equations. Operating in the same manner, a Voltage Controlled High-Pass Filter is shown in Figure 29. Higher order filters can be made using additional amplifiers as shown in Figures 30 and 31.

**Voltage-Controlled Oscillators**

Figure 32 shows a voltage-controlled triangle-square wave generator. With the indicated values a range from 2.0 Hz to 200 kHz is possible by varying  $I_{ABC}$  from 1.0 mA to 10  $\mu$ A.

The output amplitude is determined by  $I_{OUT} \times R_{OUT}$ .

Please notice the differential input voltage is not allowed to be above 5.0 V.

With a slight modification of this circuit you can get the sawtooth pulse generator, as shown in Figure 33.

**APPLICATION HINTS**

To hold the transconductance  $g_M$  within the linear range,  $I_{ABC}$  should be chosen not greater than 1.0 mA. The current mirror ratio should be as accurate as possible over the entire current range. A current mirror with only two transistors is not recommended. A suitable current mirror can be built with a PNP transistor array which causes excellent matching and thermal coupling among the transistors. The output current range of the DAC normally reaches from 0 to -2.0 mA. In this application, however, the current range is set through  $R_{REF}$  (10 k $\Omega$ ) to 0 to -1.0 mA.

$$I_{DACMAX} = 2 \cdot \frac{V_{REF}}{R_{REF}} = 2 \cdot \frac{5V}{10k\Omega} = 1mA$$

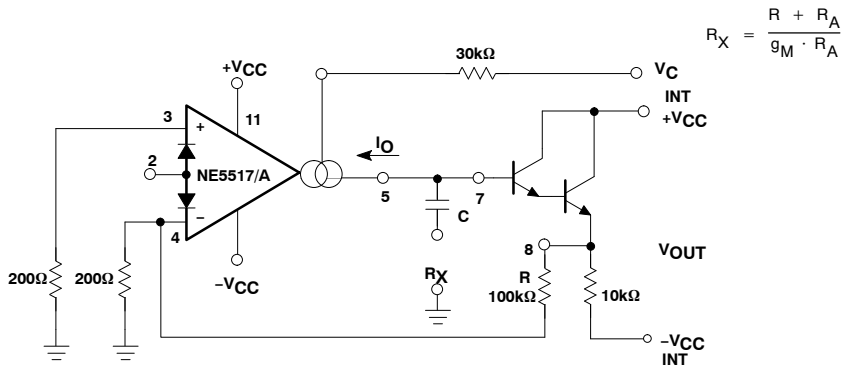


Figure 26. VCR

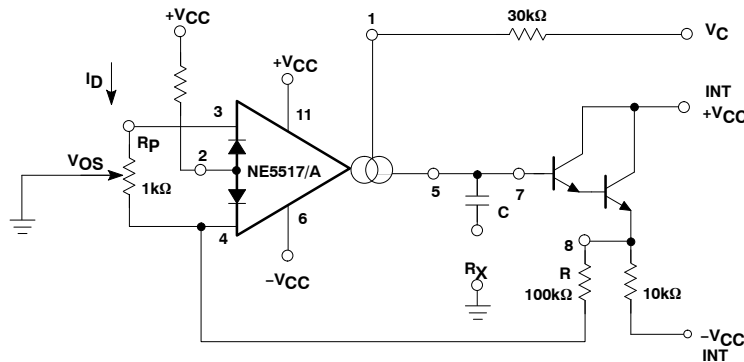
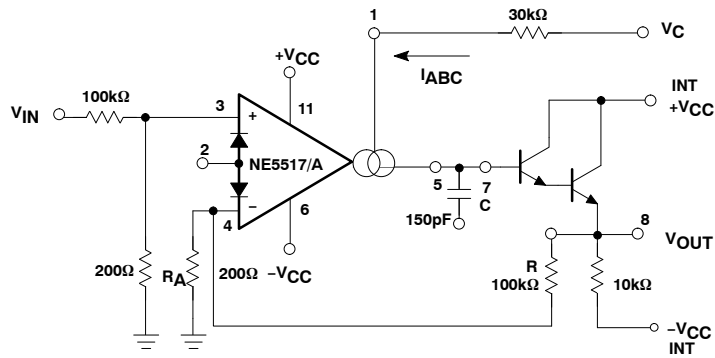


Figure 27. VCR with Linearizing Diodes

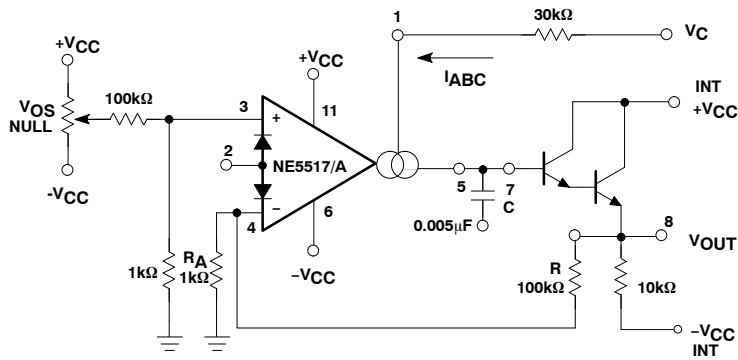
# NE5517, NE5517A, AU5517



NOTE:

$$f_O = \frac{R_A g_M}{g(R + R_A) 2\pi C}$$

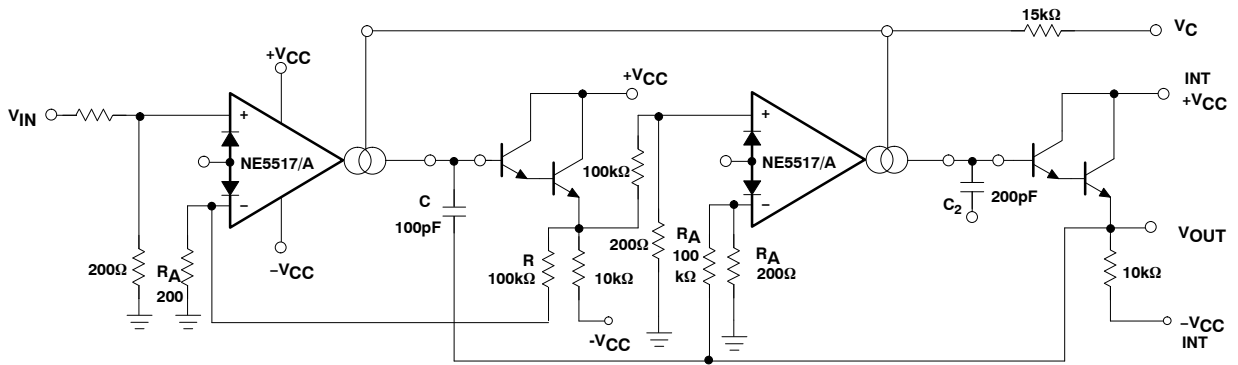
Figure 28. Voltage-Controlled Low-Pass Filter



NOTE:

$$f_O = \frac{R_A g_M}{g(R + R_A) 2\pi C}$$

Figure 29. Voltage-Controlled High-Pass Filter



NOTE:

$$f_O = \frac{R_A g_M}{(R + R_A) 2\pi C}$$

Figure 30. Butterworth Filter - 2nd Order

# NE5517, NE5517A, AU5517

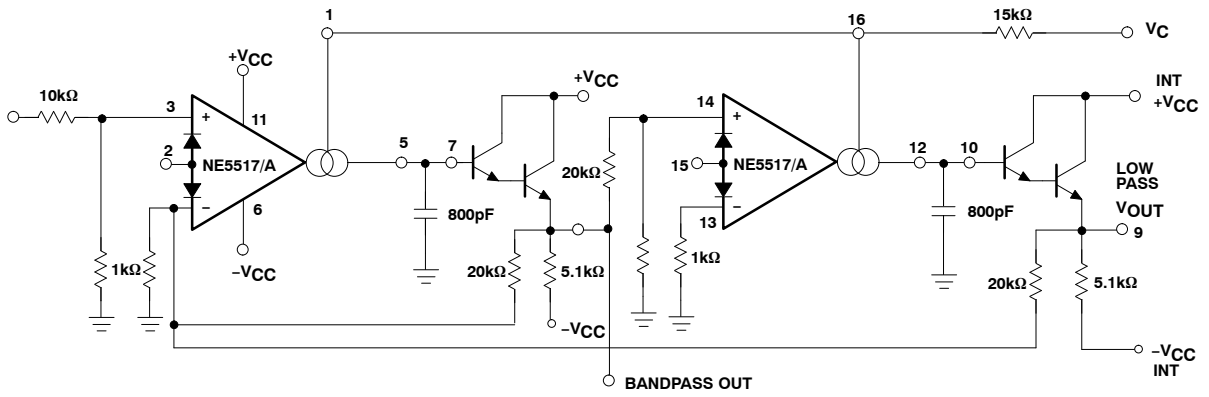


Figure 31. State Variable Filter

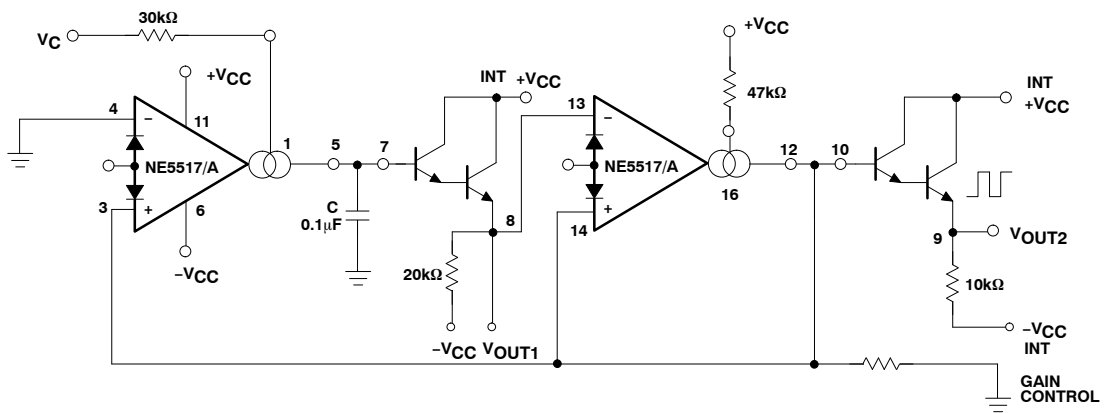


Figure 32. Triangle-Square Wave Generator (VCO)

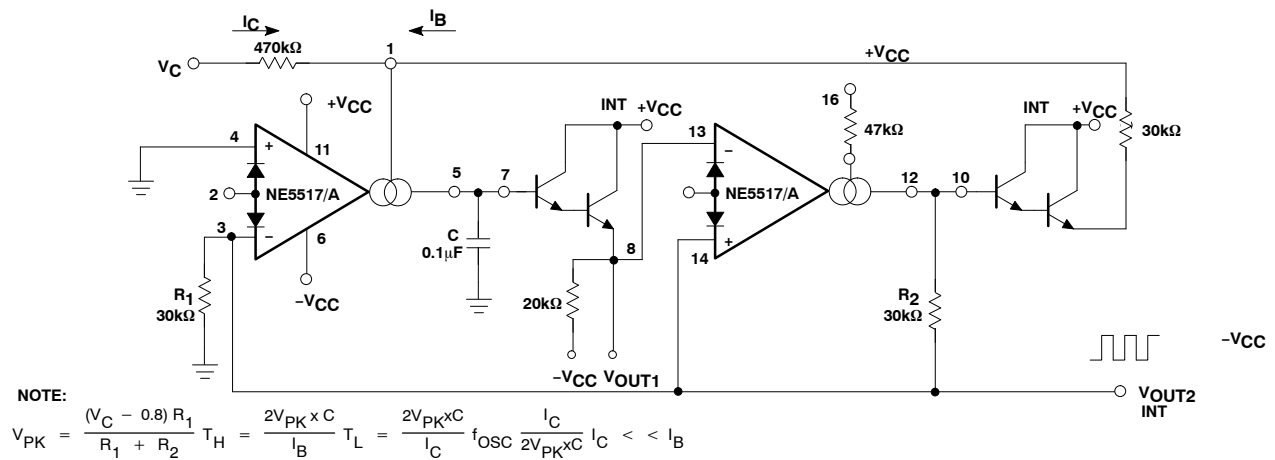


Figure 33. Sawtooth Pulse VCO

## NE5517, NE5517A, AU5517

### ORDERING INFORMATION

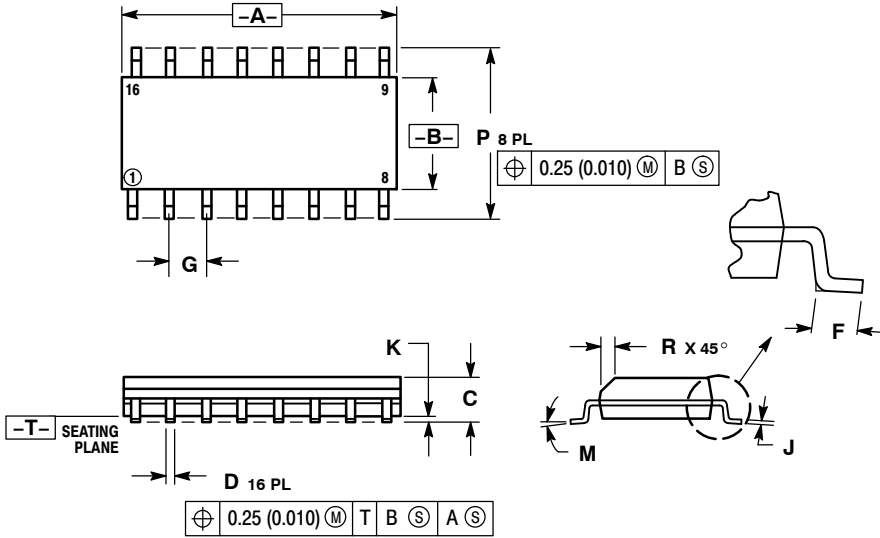
| Device     | Temperature Range | Package              | Shipping†        |
|------------|-------------------|----------------------|------------------|
| AU5517DR2  | -40 to +125 °C    | SOIC-16              | 2500 Tape & Reel |
| AU5517DR2G |                   | SOIC-16<br>(Pb-Free) |                  |
| NE5517D    | 0 to +70 °C       | SOIC-16              | 48 Units/Rail    |
| NE5517DG   |                   | SOIC-16<br>(Pb-Free) |                  |
| NE5517DR2  |                   | SOIC-16              | 2500 Tape & Reel |
| NE5517DR2G |                   | SOIC-16<br>(Pb-Free) |                  |
| NE5517N    |                   | PDIP-16              | 25 Units/Rail    |
| NE5517NG   |                   | PDIP-16<br>(Pb-Free) |                  |
| NE5517AN   |                   | PDIP-16              |                  |
| NE5517ANG  |                   | PDIP-16<br>(Pb-Free) |                  |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NE5517, NE5517A, AU5517

## PACKAGE DIMENSIONS

SOIC-16  
CASE 751B-05  
ISSUE K

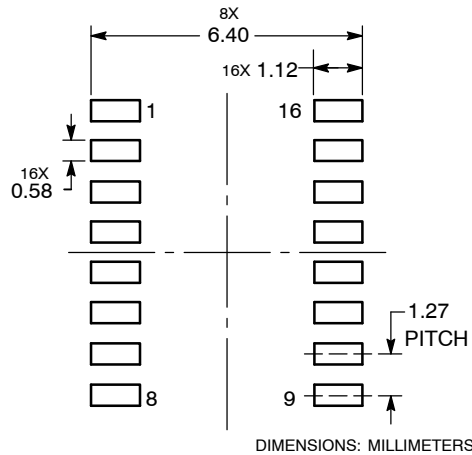


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

| DIM | MILLIMETERS |       | INCHES    |       |
|-----|-------------|-------|-----------|-------|
|     | MIN         | MAX   | MIN       | MAX   |
| A   | 9.80        | 10.00 | 0.386     | 0.393 |
| B   | 3.80        | 4.00  | 0.150     | 0.157 |
| C   | 1.35        | 1.75  | 0.054     | 0.068 |
| D   | 0.35        | 0.49  | 0.014     | 0.019 |
| F   | 0.40        | 1.25  | 0.016     | 0.049 |
| G   | 1.27 BSC    |       | 0.050 BSC |       |
| J   | 0.19        | 0.25  | 0.008     | 0.009 |
| K   | 0.10        | 0.25  | 0.004     | 0.009 |
| M   | 0°          | 7°    | 0°        | 7°    |
| P   | 5.80        | 6.20  | 0.229     | 0.244 |
| R   | 0.25        | 0.50  | 0.010     | 0.019 |

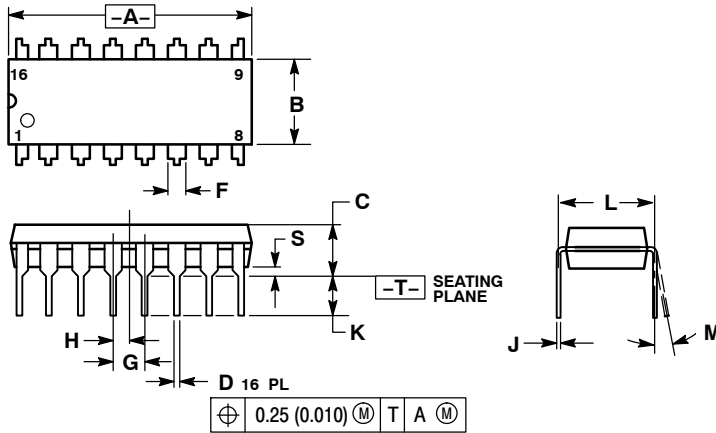
### SOLDERING FOOTPRINT



# NE5517, NE5517A, AU5517

## PACKAGE DIMENSIONS

PDIP-16  
CASE 648-08  
ISSUE U



### NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
5. ROUNDED CORNERS OPTIONAL.

| DIM | INCHES    |       | MILLIMETERS |       |
|-----|-----------|-------|-------------|-------|
|     | MIN       | MAX   | MIN         | MAX   |
| A   | 0.740     | 0.770 | 18.80       | 19.55 |
| B   | 0.250     | 0.270 | 6.35        | 6.85  |
| C   | 0.145     | 0.175 | 3.69        | 4.44  |
| D   | 0.015     | 0.021 | 0.39        | 0.53  |
| F   | 0.040     | 0.70  | 1.02        | 1.77  |
| G   | 0.100 BSC |       | 2.54 BSC    |       |
| H   | 0.050 BSC |       | 1.27 BSC    |       |
| J   | 0.008     | 0.015 | 0.21        | 0.38  |
| K   | 0.110     | 0.130 | 2.80        | 3.30  |
| L   | 0.295     | 0.305 | 7.50        | 7.74  |
| M   | 0°        | 10°   | 0°          | 10°   |
| S   | 0.020     | 0.040 | 0.51        | 1.01  |

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